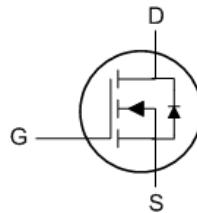
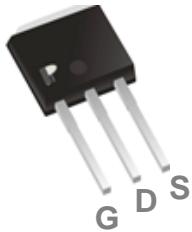


General Description

These N-Channel enhancement mode power field effect transistors are using Super Junction technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply

TO251 Pin Configuration



BVDSS	RDSON	ID
700V	0.93Ω	4A

Features

- 4A, 700V, $RDS(ON) = 0.93\Omega$ @ $VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- High efficient switched mode power supplies
- LED Lighting
- Adapter/charger

Absolute Maximum Ratings ($T_C=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	700	V
V_{GS}	Gate-Source Voltage	± 30	V
I_D	Drain Current – Continuous ($T_C=25^\circ C$)	4	A
	Drain Current – Continuous ($T_C=100^\circ C$)	2.5	A
I_{DM}	Drain Current – Pulsed	(Note 1)	A
EAS	Single Pulse Avalanche Energy	(Note 2)	mJ
IAS	Single Pulse Avalanche Current	(Note 2)	A
P_D	Power Dissipation ($T_C=25^\circ C$)	50	W
	Power Dissipation – Derate above $25^\circ C$	0.4	W/ $^\circ C$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ C$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ C$

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient	---	62	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance Junction to Case	---	2.5	$^\circ C/W$



700V N-Channel MOSFETs

PJR04N70L

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)**Off Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_{\text{D}}=250\mu\text{A}$	700	---	---	V
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=700\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	1	μA
		$V_{\text{DS}}=700\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=125^\circ\text{C}$	---	10	---	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 30\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA

On Characteristics

$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}}=10\text{V}$, $I_{\text{D}}=2\text{A}$	---	0.83	0.93	Ω
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_{\text{D}}=250\mu\text{A}$	2.5	3.5	4.5	V

Dynamic and switching Characteristics

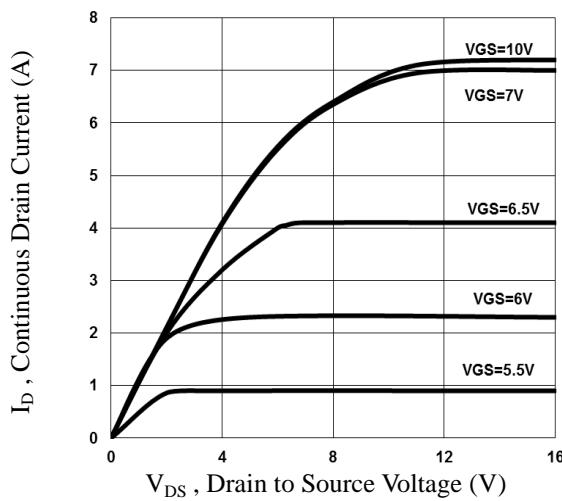
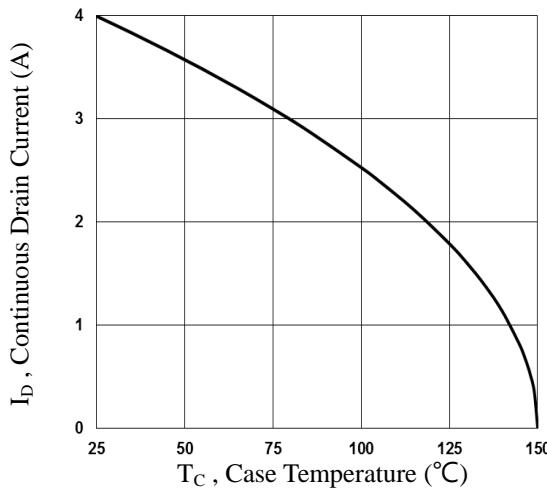
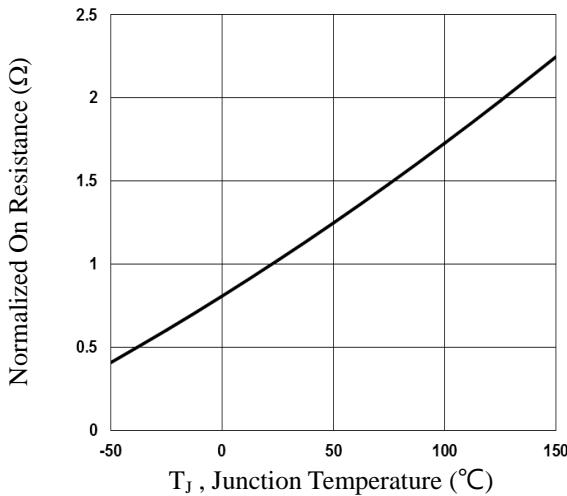
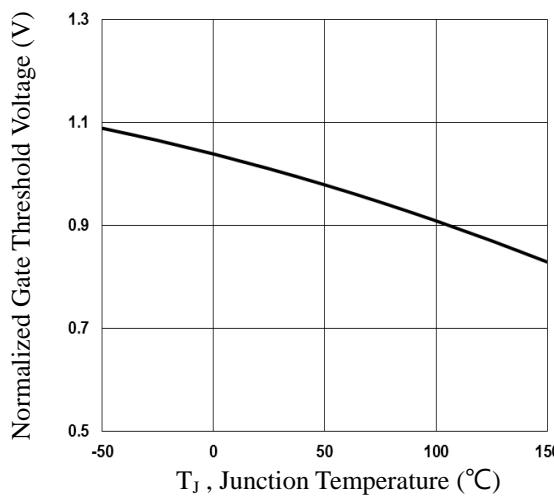
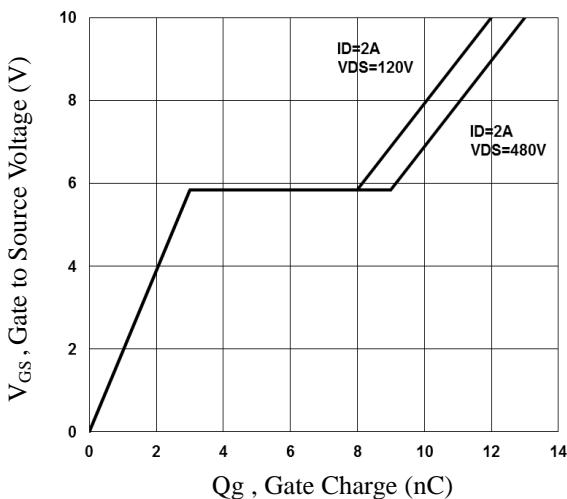
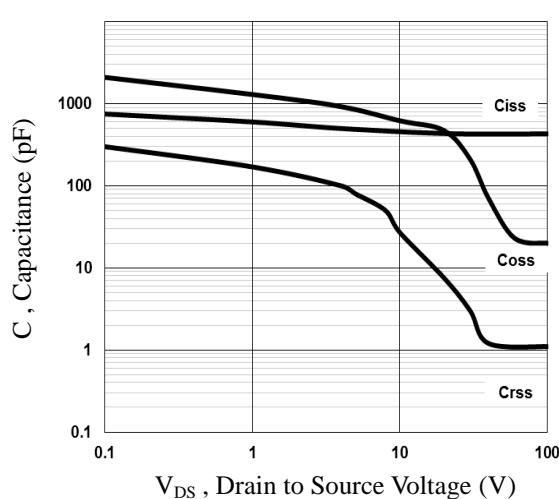
Q_g	Total Gate Charge (10V)	$V_{\text{DS}}=480\text{V}$, $V_{\text{GS}}=10\text{V}$, $I_{\text{D}}=2\text{A}$ (Note 4,5)	---	13	20	nC
Q_{gs}	Gate-Source Charge		---	3	6	
Q_{gd}	Gate-Drain Charge		---	6	12	
$T_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}}=300\text{V}$, $V_{\text{GS}}=10\text{V}$, $R_{\text{G}}=12\Omega$, $I_{\text{D}}=2\text{A}$ (Note 4,5)	---	13	20	ns
T_r	Rise Time		---	12	19	
$T_{\text{d(off)}}$	Turn-Off Delay Time		---	31	50	
T_f	Fall Time		---	9	17	
C_{iss}	Input Capacitance	$V_{\text{DS}}=25\text{V}$, $V_{\text{GS}}=0\text{V}$, $F=1\text{MHz}$	---	450	700	pF
C_{oss}	Output Capacitance		---	300	450	
C_{rss}	Reverse Transfer Capacitance		---	5	10	

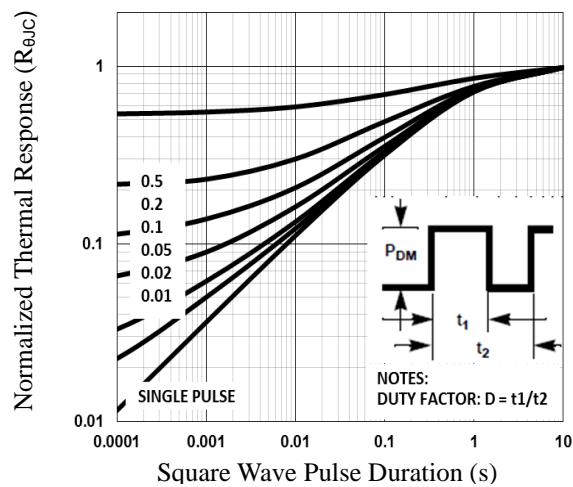
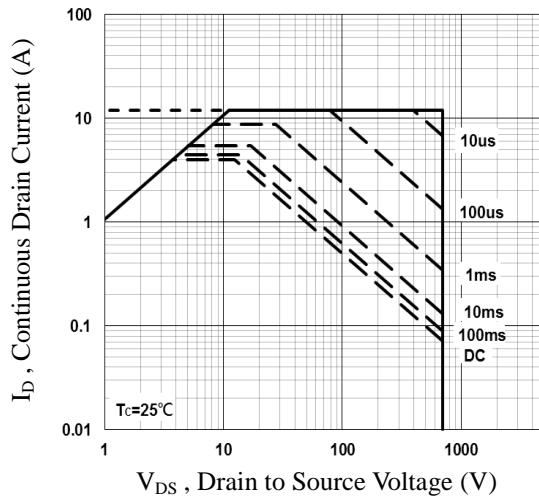
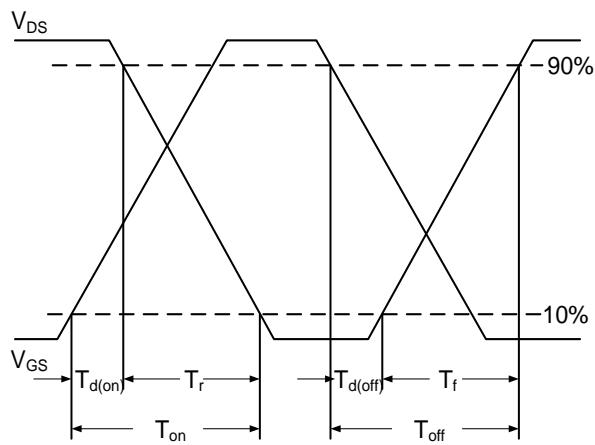
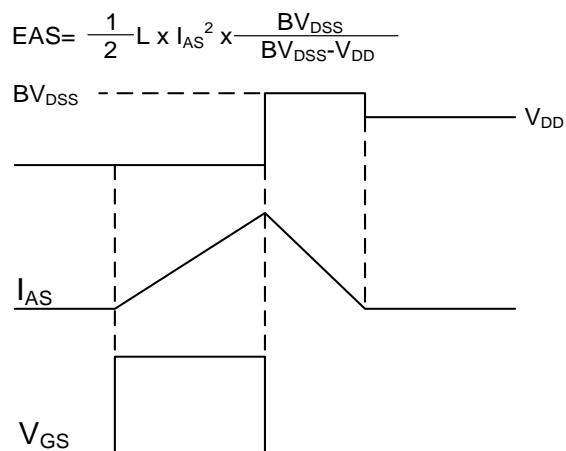
Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current	$V_G=V_D=0\text{V}$, Force Current	---	---	4	A
I_{SM}	Pulsed Source Current		---	---	8	A
V_{SD}	Diode Forward Voltage	$V_{\text{GS}}=0\text{V}$, $I_s=2\text{A}$, $T_J=25^\circ\text{C}$	---	---	1.2	V
t_{rr}	Reverse Recovery Time		---	220	---	ns
Q_{rr}	Reverse Recovery Charge	(Note 4)	---	1.6	---	μC

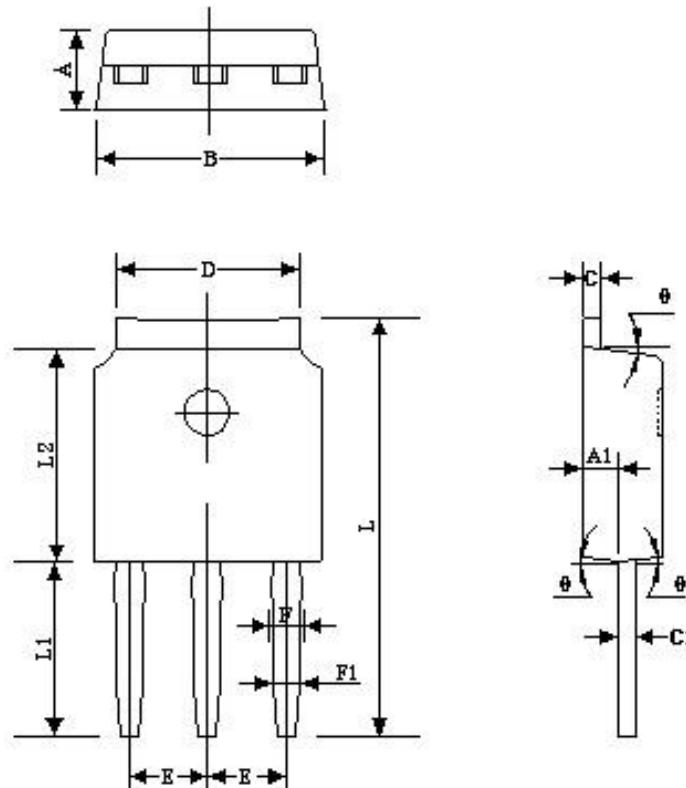
Note :

- Repetitive Rating : Pulsed width limited by maximum junction temperature.
- $V_{\text{DD}}=50\text{V}$, $V_{\text{GS}}=10\text{V}$, $L=10\text{mH}$, $I_s=3\text{A}$, $R_{\text{G}}=1.46\Omega$, Starting $T_J=25^\circ\text{C}$.
- $I_{\text{SD}} \leq 2\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{\text{DD}} \leq \text{BV}_{\text{DSS}}$, Starting $T_J=25^\circ\text{C}$.
- The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
- Essentially independent of operating temperature.


Fig.1 Output Characteristics

Fig.2 Continuous Drain Current vs. T_c

Fig.3 Normalized R_{DSON} vs. T_J

Fig.4 Normalized V_{th} vs. T_J

Fig.5 Gate Charge Waveform

Fig.6 Capacitance Characteristics


Fig.7 Normalized Transient Impedance

Fig.8 Maximum Safe Operation Area

Fig.9 Switching Time Waveform

Fig.10 EAS Waveform

TO251 PACKAGE INFORMATION



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	2.400	2.200	0.094	0.087
A1	1.110	0.910	0.044	0.036
B	6.700	6.500	0.264	0.256
C	0.580	0.460	0.023	0.018
C1	0.580	0.460	0.023	0.018
D	5.460	5.100	0.215	0.201
E	2.386	2.186	0.094	0.086
F	0.940	0.740	0.037	0.029
F1	0.860	0.660	0.034	0.026
L	12.300	11.700	0.484	0.461
L1	5.200	4.800	0.205	0.189
L2	6.200	6.000	0.244	0.236
θ	9°	3°	9°	3°